

Notice of References Cited	Application/Control No. 10/674,576	Applicant(s)/Patent Under Reexamination CHUN ET AL.	
	Examiner DuyVu n. Deo	Art Unit 1765	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,072,190	06-2000	Watanabe et al.	257/48
	C	US-2004/0201390	10-2004	Farnworth et al.	324/754
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	M	US-			

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NON-PATENT DOCUMENTS

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